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## **SEE Characterization of a Magnetometer Front-End ASIC using a RHBD Digital Library in AMS 0.35um CMOS**

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A radiation-hardened-by-design (RHBD) digital library, developed for the Austria Microsystems (AMS) 0.35um CMOS technology has been applied in a mixed-signal ASIC that operates as a multi-channel data acquisition system for magnetometers using anisotropic magneto-resistances (AMR). The circuit has been tested in the Heavy-Ion facilities of the Université Catholique de Louvain-la-Neuve (HIF-UCL). The experimental results demonstrate a LET threshold of 22.5 MeV·cm<sup>2</sup>/mg and absence of latchup up to 81.8 MeV·cm<sup>2</sup>/mg. SEE performance of the A/D converters has also been measured. This radiation-tolerant performance is obtained at the cost of a penalty in area and power with respect to the unhardened technology.

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